

Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All recreations are done with the approval of the OCM.

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceed the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-35835
 - Class Q Military
 - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
- Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OEM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.

87C51/87C52T2



8-Bit CMOS Microcontrollers

PRELIMINARY

DISTINCTIVE CHARACTERISTICS

- Software- and pin-compatible with 80C51
- Beneficial for prototyping and initial production
- All 80C51BH and 80C52T2 features retained FlashriteTM EPROM programming
- Two-level Program Memory Lock
- 32-Byte Encryption Array
- In-Circuit Test Mode facilitates testing

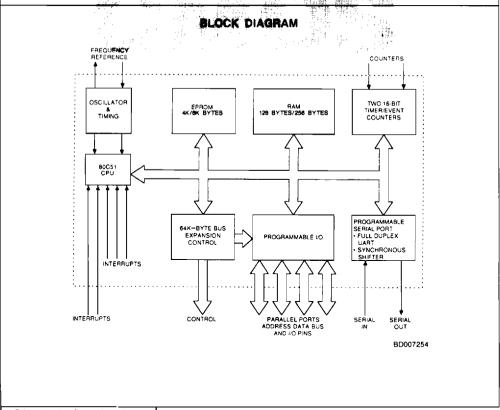
	RAM (bytes)	EPROM (bytes)
87C51	128	4K
87C52T2	256	8K

87C51 # User-programmable 80C51BH 87C52T2 = User-programmable 80C52T2

GENERAL DESCRIPTION

The 87C51 and 87C52T2 are CMOS EPROM versions of the 80C51BH and 80C52T2, respectively. The 87C51 includes 4K bytes of on-chip EPROM, and the 87C52T2 includes 8K bytes of EPROM.

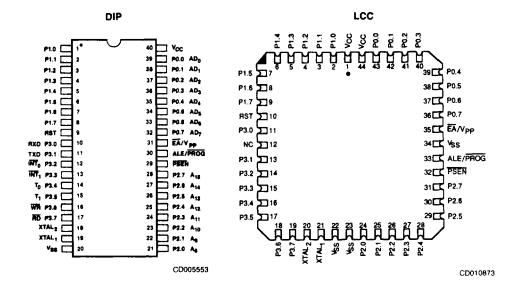
These user-programmable products are software- and pincompatible with their ROM-based counterparts. All of the 80C52BH and 80C52T2 features are retained. For more information consult the 80C51/80C31BH/80C52T2/80C32T2 data sheet (order #04815). Additionally, several new features are offered on the EPROM versions. The 87C51 and 87C52T2 EPROM array support the Flashrite programming algorithm that allows a 4K-byte EPROM array to be programmed in approximately 12 seconds. A two-level programmable lock structure prevents externally fetched code from accessing internal Program Memory and can disable EPROM verification and programming. A 32-byte Encryption Array can be used to encode the program code bytes during EPROM verification.



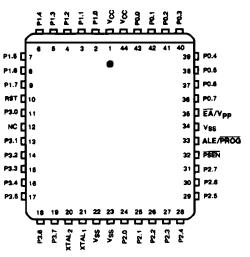
Amendment

87C51/87C52T2

CONNECTION DIAGRAMS Top View



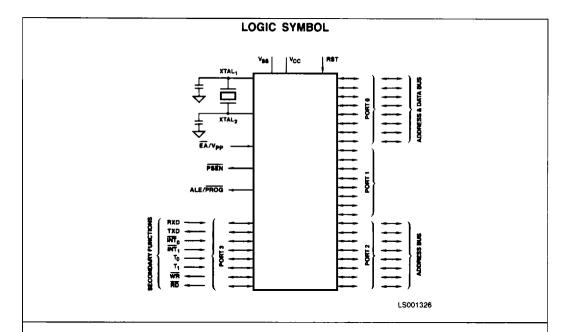
PLCC



CD009442

Notes: Pin 1 is marked for orientation.

NC pins on the PLCC and LCC packages have been utilized as additional V_{CC} and V_{SS} connections to improve noise immunity. It is recommended that these pins (1, 23, and 37) be connected appropriately; however, they may be left floating to insure second source compatibility.

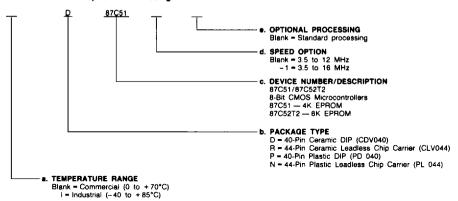


ORDERING INFORMATION

Commodity Products

AMD commodity products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of: a. Temperature Range

- b. Package Type
- c. Device Number
- d. Speed Option
- e. Optional Processing



Valid Combinations 87C51 87C51-1 D, R, P, N 87C51-1 ID, IR, IP, IN 87C52T2 87C52T2-1 87C52T2-1

Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations, to check on newly released combinations, and to obtain additional data on AMD's standard military grade products.

PIN DESCRIPTION

Port 0 (Bidirectional; Open Drain)

Port 0 is an open-drain I/O port. Port 0 pins that have 1s written to them float, and in that state can be used as high-impedance inputs.

Port 0 is also the multiplexed low-order address and data bus during accesses to external Program and Data Memory. In this application it uses strong internal pullups when emitting 1s. Port 0 also outputs the code bytes during program verification in the 87C51/87C52T2. External pullups are required during program verification.

Port 1 (Bidirectional)

Port 1 is an 8-bit bidirectional I/O port with internal pullups. The Port 1 output buffers can sink/source four LS TTL inputs. Port 1 pins that have 1s written to them are pulled High by the internal pullups and can be used as inputs while in this state. As inputs, Port 1 pins that are externally being pulled Low will source current (I_{IL} on the data sheet) because of the internal pullups.

Port 1 also receives the low-order address bytes during program verification.

Port 2 (Bidirectional)

Port 2 is an 8-bit bidirectional I/O port with internal pullups. The Port 2 output buffers can sink/source four LS TTL inputs. Port 2 pins having 1s written to them are pulled High by the internal pullups and can be used as inputs while in this state. As inputs, Port 2 pins externally being pulled Low will source current ($I_{\rm IL}$) because of internal pullups.

Port 2 emits the high-order address byte during fetches from external Program Memory and during accesses to external Data Memory that use 16-bit addresses (MOVX @DPTR). In this application it uses strong internal pullups when emitting 1s. During accesses to external Data Memory that use 8-bit addresses (MOVX @Ri), Port 2 emits the contents of the P2 Special Function register.

Port 2 also receives the high-order address bits during the programming of the EPROM and during program verification of the EPROM, as well as some control signals.

Port 3 (Bidirectional)

Port 3 is an 8-bit bidirectional I/O port with internal pullups. The Port 3 output buffers can sink/source four LS TTL inputs. Port 3 pins having 1s written to them are pulled High by the internal pullups and can be used as inputs while in this state. As inputs, Port 3 pins externally being pulled Low will source current (I_{IL}) because of the pullups. Port 3 also receives some control signals for EPROM programming and program verification.

Port 3 also serves the functions of various special features as listed below:

Port Pin	Alternate Function
P _{3.0}	RxD (Serial Input Port)
P _{3.1}	TxD (Serial Output Port)
P _{3.2}	INT ₀ (External Interrupt 0)
P _{3.3}	INT ₁ (External Interrupt 1)
P _{3.4}	To (Timer 0 External Input)
P _{3.5}	T ₁ (Timer 1 External Input)
P _{3.6}	WR (External Data Memory Write Strobe)
P _{3.7}	RD (External Data Memory Read Strobe)

RST Reset (Input; Active High)

This pin is used to reset the device when held High for two machine cycles while the oscillator is running. A small internal resistor permits power-on reset using only a capacitor connected to V_{CC}.

ALE/PROG Address Latch Enable/Program Pulse (Input/Output)

Address Latch Enable is the output pulse for latching the low byte of the address during accesses to external memory. ALE can drive eight LS TTL inputs.

In normal operation ALE is emitted at a constant rate of 1/6 the oscillator frequency, allowing use for external-timing or clocking purposes. Note, however, that one ALE pulse is skipped during each access to external Data Memory. This pin also accepts the program pulse input (PROG) when programming the EPROM.

PSEN Program Store Enable (Output; Active Low)

PSEN is the read strobe to external Program Memory. PSEN can drive eight LS TTL inputs. When the device is executing code from an external program memory, PSEN is activated twice each machine cycle—except that two PSEN activations are skipped during each access to external Data Memory. PSEN is not activated during fetches from internal Program Memory.

EA/Vpp External Access Enable/Programming Voltage (input; Active Low)

EA must be externally held Low to enable the device to fetch code from external Program Memory locations 0000H to 0FFFH. If EA is held High, the 87C51/87C52T2 executes from internal Program Memory unless the program counter contains an address greater than 0FFFH.

This pin also receives the 12.75-V programming supply voltage during programming of the EPROM.

XTAL₁ Crystal (Input)

Input to the inverting-oscillator amplifier, and input to the internal clock-generator circuits.

XTAL₂ Crystal (Output)

Output of the inverting-oscillator amplifier.

V_{CC} Power Supply

Power supply during normal, idle, and power-down operations.

V_{SS} Circuit Ground

PROGRAMMING

The 87C51/87C52T2 can be programmed with the Flashrite algorithm. It differs from other methods in the value used for Vpp (programming supply voltage) and in the width and number of the ALE/PROG pulses.

To program the EPROM, either the internal or external oscillator must be running between 4 and 6 MHz, since the internal bus is used to transfer address and program data to the appropriate internal registers. Table 1 shows the various EPROM programming modes.

TABLE 1. EPROM PROGRAMMING MODES FOR THE 87C51/87C52T2

Mode	RST	PSEN	ALE/PROG	ËA/V _{PP}	P2.7	P2.6	P3.7	P3.6
Program Code	н	L	L*	Vpp	н	L	н	н
Verify Code	н	L	н	V _{PPX}	L	L	н	Н
Pgm Encryption Table	н	L	Γ.	Vpp	н	Ł	н	L
Pgm Lock Bit 1	н	L	L*	V _{PP}	н	н	Н	н
Pgm Lock Bit 2	н	L	L*	V _{PP}	н	н	L	L
Read Silicon Signature	Н	L	н	н	L	L	L	L

Key: H

= Logic High for that pin

L = Logic Low for that pin

Vpp = 12.75 V ±0.25 V

V_{CC} = 5 V ±10% during programming and verification

2.0 V < V_{PPX} < 13.0 V

*ALE/PROG receives 25 programming pulses while Vpp is held at 12.75 V. Each programming pulse is low for 100 μ s (±10% μ s) and high for a minimum of 10 μ s.

Programming

The programming configuration is shown in Figure 1. The address of the EPROM location to be programmed is applied to Ports 1 and 2 as shown in the figure. The programming configuration of the 87C52T2 is identical except that P2.4 is also used as an address input. The code byte to be programmed into that location is applied to Port 0. Once RST, PSEN, Port 2, and Port 3 are held to the levels indicated in

Figure 1, ALE/PROG is pulsed low 25 times as shown in Figure 2.

The maximum voltage applied to the EA/Vpp pin must not exceed 13 V at any time as specified for Vpp. Even a slight spike can cause permanent damage to the device. The Vpp source should thus be well regulated and glitch-free.

When programming, a 0.1 µF capacitor is required across Vpp and ground to suppress spurious transients which may damage the device.

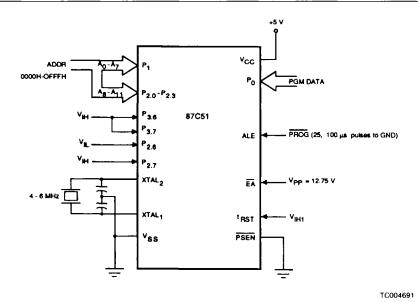


Figure 1. 87C51 Programming Configuration

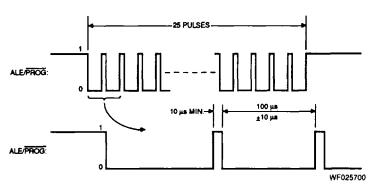


Figure 2. PROG Waveforms

Program Verification

The 87C51/87C52T2 provides a method of reading the programmed code bytes in the EPROM array for program verification. This function is possible as long as Lock Bit 2 has not been programmed.

For program verification, the address of the Program Memory location to be read is applied to Ports 1 and 2 as shown in

Figure 3. Verification of the 87C52T2 is identical except that P2.4 is also used as an address input. Once RST, PSEN, Port 2, and Port 3 are held to the levels indicated, the contents of the addressed location will be emitted on Port 0. External pullups are required on Port 0 for this operation. The EPROM programming and verification waveforms provide further details.

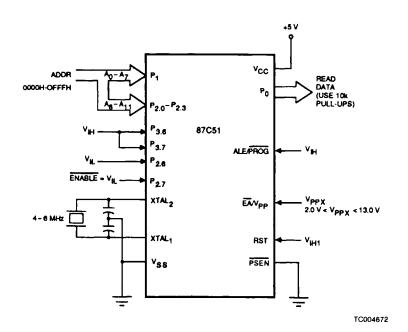


Figure 3. 87C51 Program Verification

Program Encryption Table

The 87C51/87C52T2 features a 32-byte Encryption Array. It can be programmed by the customer, thus encrypting the program code bytes read during EPROM verification. The EPROM verification procedure is performed as usual except that each code byte comes out logically X-NORed with one of the 32 key bytes.

The key byte used is the one whose address corresponds to the lower 5 bits of the EPROM verification address. Thus, when the EPROM is verified starting with address 0000H, all 32 keys in their correct sequence must be known. Unprogrammed bytes have the value FFH. Thus, if the Encryption Table is left unprogrammed, no encryption will be performed, since any byte X-NORed with FFH leaves that byte unchanged.

To program the Encryption Table, programming is set up as usual, except that P3.6 is held Low, as shown in Table 1. The 25-pulse programming sequence is applied to each address, 00 through 1FH. The programming of these bytes does not affect the standard 4K-byte EPROM array. When the Encryption Table is programmed, the Program Verify operation will produce only encrypted data.

The Encryption Table cannot be directly read. The programming of Lock Bit 1 will disable further Encryption Table programming.

Security Lock Bits

The 87C51 contains two Lock Bits which can be programmed to obtain additional security features. P = Programmed and U = Unprogrammed.

Lock Bit 1	Lock Bit 2	Result
U	U	Normal Operation
Р	U	Externally fetched code cannot access internal Program Memory All further Programming disabled (except Lock Bit 2)
U	Р	Reserved
Р	Р	Externally fetched code cannot access internal Program Memory All further Programming disabled Program Verification disabled

To program the Lock Bits, a 100 pulse programming sequence is required using the levels shown in Table 1. After Lock Bit 1 is programmed, further programming of the Code Memory and Encryption Table is disabled. However, Lock Bit 2 may still be programmed, providing the highest level of security available on the 87C51/87C52T2.

When Lock Bit 1 is programmed, the logic level at the \overline{EA} pin is sampled and latched during reset. If the device is powered up without a reset, the latch initializes to a random value, and holds that value until reset is activated. It is necessary that the latched value of \overline{EA} be in agreement with the current logic level at that pin in order for the device to function properly.

Silicon Signature Verification

AMD supports silicon signature verification for the 87C51/87C52T2. The manufacturer code and part code can be read from the device before any programming is done to enable the EPROM Programmer to recognize the device.

To read the silicon signature, the external pins are set up as shown in Figure 4. This procedure is the same as a normal verification except that P3.6 and P3.7 are pulled to a logic Low. The values returned are:

Manufacturer Code	Address: 0030H	Code: 01H
87C51 Part Code	Address: 0031H	Code: B0H
87C52T2 Part Code	Address: 0031H	Code: 31H

Code 01H indicates AMD as the manufacturer. Code B0H indicates the device type is the 87C51, and Code 31H indicates a 87C52T2.

In-Circuit Test Mode

The In-Circuit Test Mode facilitates testing and debugging of systems using the 87C51 without the 87C51 having to be removed from the circuit. The In-Circuit Test Mode is invoked by:

- 1. Pulling ALE Low while RST is held High, and PSEN is High.
- 2. Holding ALE Low as RST is de-activated.

While the device is in In-Circuit Test Mode, the Port 0 pins go into a float state, and the other port pins and ALE and PSEN are weakly pulled High. The oscillator circuit remains active. While the 87C51 is in this mode, an emulator or test CPU can be used to drive the circuit. Normal operation is restored when a Hardware Reset is applied.

Erasure Characteristics

Light and other forms of electromagnetic radiation can lead to erasure of the EPROM when exposed for extended periods of time.

Wavelengths of light shorter than 4000 angstroms, such as sunlight or indoor fluorescent lighting, can ultimately cause inadvertent erasure and should, therefore, not be allowed to expose the EPROM for lengthy durations (approximately one week in sunlight or three years in room-level fluorescent lighting). It is suggested that the window be covered with an opaque label if an application is likely to subject the device to this type of radiation.

It is recommended that ultraviolet light (of 2537 angstroms) be used to a dose of at least 15 W-sec/cm² when erasing the EPROM. An ultraviolet lamp rated at 12,000 μW/cm² held one inch away for 20–30 minutes should be sufficient.

EPROM erasure leaves the Program Memory in an "all ones" state

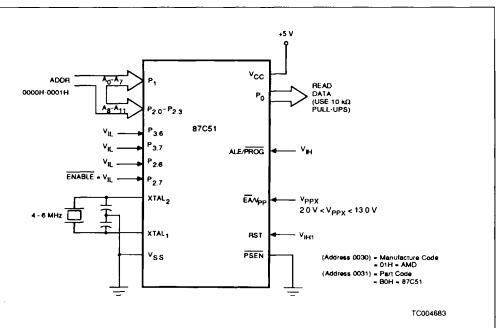


Figure 4. 87C51 Silicon Signature Verification Configuration

Oscillator Characteristics

XTAL₁ and XTAL₂ are the input and output, respectively, of an inverting amplifier which is configured for use as an on-chip oscillator (see Figure 5). Either a quartz crystal or ceramic resonator may be used.

To drive the device from an external clock source, $XTAL_1$ should be driven while $XTAL_2$ is left unconnected (see Figure 6). There are no requirements on the duty cycle of the external clock signal since the input to the internal clocking circuitry is through a divide-by-two flip-flop, but minimum and maximum High and Low times specified on the data sheet must be observed.

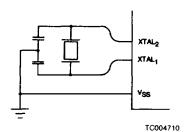


Figure 5. Crystal Oscillator



Figure 6. External Drive Configuration

ABSOLUTE MAXIMUM RATINGS

Storage Temperature	65 to +150°C
Voltage on EA/Vpp Pin to Vss	
Voltage on VCC to Vss	
Voltage on Any Other Pin to Vss	0.5 to +6.5 V
Power Dissipation	200 mW/

Stresses above those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to absolute maximum ratings for extended periods may affect device reliability.

OPERATING RANGES

Supply Voltage (V _{CC})	(T _A) 0 to +70°C +4.5 to +5.5 V 0 V
Supply Voltage (V _{CC})	(T _A)40 to +85°C+4.5 to +5.5 V0 V

Operating ranges define those limits between which the functionality of the device is guaranteed.

DC CHARACTERISTICS over operating ranges

Parameter Symbol	Parameter Description	Test Conditions	Min.	Max.	Unit
VIL	Input Low Voltage (Except EA)	1	-0.5	0.2 V _{CC} - 0.1	٧
V _{IL1}	Input Low Voltage (EA)		0	0.2 V _{CC} - 0.3	>
V _{IH}	Input High Voltage (Except XTAL ₁ , RST)		0.2 V _{CC} + 0.9	V _{CC} + 0.5	٧
V _{IH1}	Input High Voltage to XTAL1, RST		0.7 V _{CC}	V _{CC} + 0.5	V
VOL	Output Low Voltage (Ports 1, 2, 3)	lot = 1.4 mg (No. 1)		0.45	>
V _{OL1}	Output Low Voltage (Port 0, ALE, PSEN)	3.2 PIA NOTE 1)		0.45	٧
Voн	Output High Voltage (Ports 1, 2, 3), ALE, PSAN	OH 60 14, CC V ± 10%	2.4		٧
		IOH = -10 µA	0.9 V _{CC}		
V _{OH1}	Output High Voltage (Port Con Etherna Bus Mode)	I _{OH} = -800 μA, V _{CC} = 5 V ±10%	2.4		٧
	MOCE)	I _{OH} = -80 μA (Note 2)			
l _{IL}	Logical 0 Input Correct (Forts 1, 2, 3)	V _{IN} = 0.45 V		-50	μĀ
ITL	Logist 1-to Instition Current (Ports 1, 2, 3)	(Note 3)		-650	μΑ
l <u>u</u>	Input spitage Current (Port 0)	V _{IN} = V _{IL} or V _{IH}		± 10	μΑ
· · · · · · · · · · · · · · · · · · ·	Power Supply Current:			Note 4	mA
lcc	Active Mode @ 12 MHz (Note 4) Idle Mode @ 12 MHz (Note 4)	(Note 5)		Note 4	
	Power-Down Mode			50	μΑ
ARST	Reset Pulldown Resistor		50	300	kΩ
C _{IO}	Pin Capacitance	Test Freq = 1 MHz, TA = 25°C		10	ρF

- Notes: 1. Capacitive loading on Ports 0 and 2 may cause spurious noise pulses to be superimposed on the V_{OL}s of ALE and Ports 1 and 3. The noise is due to external bus capacitance discharging into the Port 0 and Port 2 pins when these pins make 1-to-0 transitions during bus operations. In the worst cases (capacitive loading > 100 pF), the noise pulse on the ALE line may exceed 0.8 V. In such cases it may be desirable to qualify ALE with a Schmitt Trigger, or use an address latch with a Schmitt Trigger STROBE input.

 2. Capacitive loading on Ports 0 and 2 may cause the V_{OH} on ALE and PSEN to momentarily fall below the 0.9 V_{CC} specification when the
 - address bits are stabilizing.
 - 3. Pins of Ports 1, 2, and 3 source a transition current when they are being externally driven from 1 to 0. The transition current reaches its 3. Pins of Ports 1, 2, and 3 source a transition current when they are being externally driven from 1 to 0. The transition current reaches its maximum value when V_{III} is approximately 2 V.

 1. ICCMAX at other frequencies is given by:

 Active Mode: I_{CC} TYPICAL = 0.94 x Freq + 13.71

 I_{CC} MAX = 1.38 x Freq + 20.4

 Idle Mode: I_{CC} TYPICAL = 0.38 x Freq + 5.4

 I_{CC} MAX = 0.38 x Freq + 11.9

 where Freq is the external oscillator frequency in MHz. I_{CC}MAX is given in mA (see Figure 5).

 5. Active Mode I_{CC} is measured with all output pins disconnected; XTAL1 driven with TCLCH, TCHCL = 5 ns, V_{IL} = V_{SS} + 0.5 V, V_{IH} = V_{CC} - 0.5 V; XTAL2 N.C.; EA = RST = Port 0 = V_{CC}.

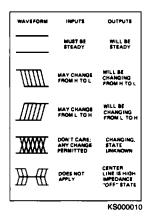
 Idle Mode I_{CC} is measured with all output pins disconnected; XTAL1 driven with TCLCH, TCHCL = 5 ns, V_{IL} = V_{SS} + 0.5 V, V_{IH} = V_{CC} - 0.5 V; XTAL2 = N.C.; Port 0 = V_{CC}: EA = RST = V_{SS}.

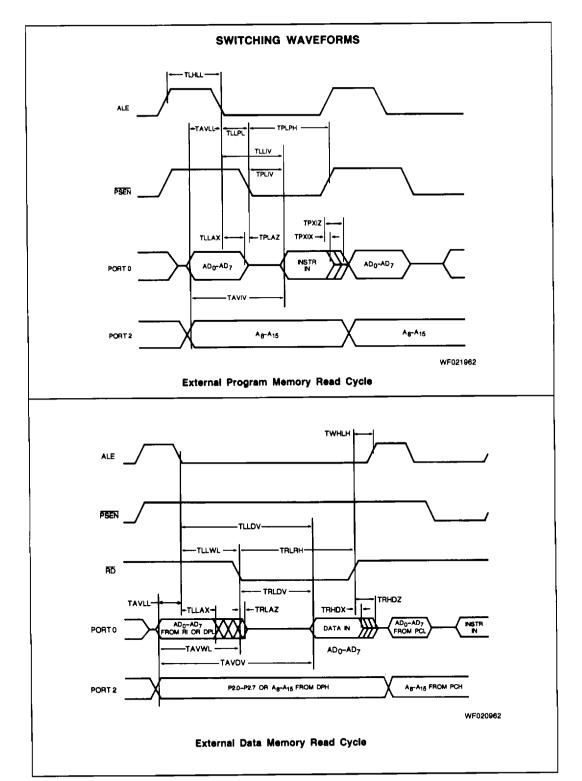
 Power-Down Mode I_{CC} is measured with all output pins disconnected; EA = Port 0 = V_{CC}: XTAL2 NC; RST = V_{SS}.

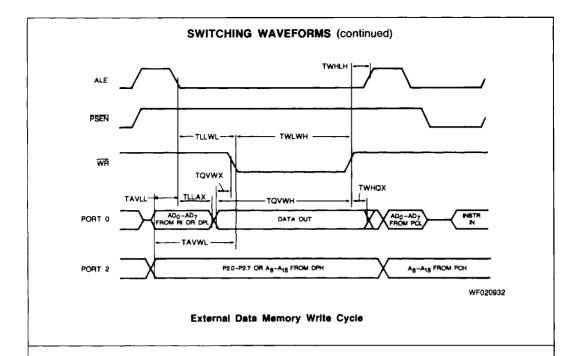
SWITCHING CHARACTERISTICS over operating ranges (Load Capacitance for Port 0, ALE, and PSEN = 100 pF, Load Capacitance for All Other Outputs = 80 pF)

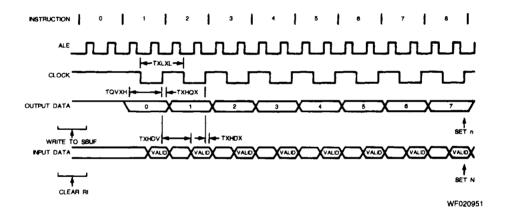
Parameter	Parameter	16 MH	z Osc.	12 MH	z Osc.	Variable	Oscillator	
Symbol	Description	Min.	Max.	Min.	Max.	Min.	Max.	Unit
1/TCLCL	Oscillator Frequency					3.5	16	MHz
TLHLL	ALE Puise Width	85		127		2TCLCL-40		ns.
TAVLL	Address Valid to ALE Low	7		28		CLCL-55		ns.
TLLAX	Address Hold After ALE Low	27		48		1 LCL-35		ns
TLLIV	ALE Low to Valid Instr. In		150		22		4TCLCL-100	ns
TLLPL	ALE LOW to PSEN LOW	22		43		TC CL-40		ns.
TPLPH	PSEN Pulse Width	142		445		3TCLCL-45		ns.
TPLIV	PSEN Low to Valid Instr. In		180, 1		145		3TCLCL- 105	DB.
TPXIX	Input Instr. Hold After PSEN	0		0		0		ns
TPXIZ	Input Instr. Float After PSEN	_	B		59		TCLCL-25	ns.
TAVIV	Address to Valid Instr. In		1		312		5TCLCL-105	ns
TPLAZ	PSEN Low to Address Float		10		10		10	ns
TALAH	RD Pulse Width	775		400		6TCLCL-100		na
TWLWH	WR Pulse Width	275		400		6TCLCL-100		ПB
TALDV	RD Low to Valid Data In.		148	T	252		5TCLCL-165	ns
TRHDX	Data Hold After	0		0		0		ns
TRHOZ	Data Float After		55		97		2TCLCL-70	ns
TLLDV	ALE Low to Valid ta in		350		517		8TCLCL-150	กร
TAVDV	Address to Valid Date in		398		585		9TCLCL-165	ns
TLLWL	ALE Low to RD or WR Low	137	238	200	300	3TCLCL-50	3TCLCL+50	ns
TAVWL	Address Valid to RD or WR Low	120		203	1	4TCLCL-130		ns
TQVWX	Data Valid to WR Transition	2		23		TCLCL-60		ns
TQVWH	Data Valid to WR High	287		433		7TCLCL-150		ns
TWHQX	Data Hold After WR	12		33		TCLCL-50		ns.
TRLAZ	RD Low to Address Float		0		0		0	ns.
TWHLH	RD or WR High to ALE High	22	103	43	123	TCLCL-40	TCLCL+ 40	ns

SWITCHING WAVEFORMS KEY TO SWITCHING WAVEFORMS





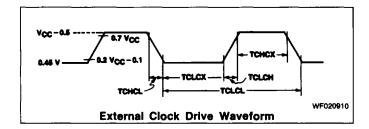




Shift Register Timing Waveforms

EXTERNAL CLOCK DRIVE

Parameter Symbol	Parameter Description	釜	Min.	Max.	Unit
1/TCLCL	Oscillator May 1889			16	MHz
TCHCX	ANOT Tine	2		W	ns
TCLCX	Low Time	蓬			ns .
TCLCH	Rise Time			20	ns ns
TCHCL	Fall Time			20	ns

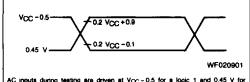


SERIAL PORT TIMING - SHIFT REGISTER MODE

(Test Conditions: $T_A = 0$ to +70°C; $V_{CC} = 5$ V ± 10 %; $V_{SS} = 0$ V; Load Capacitance = 80 pF)

Parameter	Parameter		16 I	MHz BC.	Variable	Oscillator	
Symbol	Description	4	Min.	Max.	Min.	Max.	Unit
TXLXL	Seria Politico Office Time				A ALL		ns
TQVXH	Output Dan Samp to Clark Plaing Edge	M	92		10 CLCL- 3		ns
TXHQX	Output Date Hold After Clock Rising Edge	di a	(a)		2 TOLCL-1		ns
TXHDX	Input Data Hold After Clock Rising Edge		0		0 165		ns
TXHDV	Clock Rising Edge to Input Data Valid			492		10TCLCL-133	ns

AC Testing



AC inputs during testing are driven at V_{CC}-0.5 for a logic 1 and 0.45 V for a logic 0. Timing measurements are made at V_{IH} min. for a logic 1 and V_{IL} max. for a logic 0.

Input/Output Waveform



For timing purposes a port pin is no longer floating when a 100 mV change from load voltage occurs, and begins to float when a 100 mV change from the loaded VOH/VOLlevel occurs. IOL/IOH > ±20 mA.

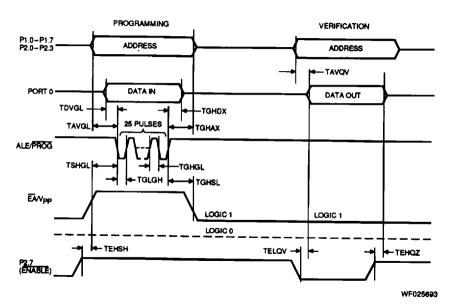
Float Waveform

EPROM PROGRAMMING AND VERIFICATION CHARACTERISTICS

 $(T_A = +21 \text{ to } +27^{\circ}\text{C})$

Parameter Symbol	Parameter Description		Max.	Unit
Vpp	Programming Supply Voltage		13.0	V
lpp	Programming Supply Current		50	mA
1/TCLCL	Oscillator Frequency		- 6	MHz
TAVGL	Address Setup to PROG	48TCLCL		
TGHAX	Address Hold After Pland	48TCLCL		
TDVGL	Data Setup to PSGG	48TCLCL		
TGHDX	Data Hold Arte PD G	48TCLCL		
TEHSH	2.7 ENA LE) Mah 10 Vpp	48TCLCL		— —
TSHGL	PROG	10		μ\$
TGHSL	Hold after PROG	10		μα
TGLGH	PROG Width	90	110	μ9
TAVQV	Address to Data Valid		48TCLCL	μο
relov	ENABLE to Data Valid		48TCLCL	
TEHQZ	Data Float After ENABLE	-	48TCLCL	
TGHGL	PROG High to PROG Low	10		

EPROM PROGRAMMING AND VERIFICATION WAVEFORMS



For Programming conditions, see Figures 1 and 2. For Verification conditions, see Figure 3.